

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/616,908	YANO, JUNICHI
	<b>Examiner</b>	<b>Art Unit</b>
	Anh Q. Tran	2819

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
as	above	7/5/05	AT